# Notice of References Cited Application/Control No. 10/571,189 Examiner ZEWDU BEYEN Applicant(s)/Patent Under Reexamination FARRELL ET AL. Page 1 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,293,379 A	03-1994	Carr, David W.	370/474
*	В	US-6,496,505 B2	12-2002	La Porta et al.	370/392
*	С	US-2003/0014544 A1	01-2003	Pettey, Christopher J.	709/249
*	D	US-2003/0076832 A1	04-2003	Ni, Shih-Hsiung	370/395.1
*	Е	US-6,614,808 B1	09-2003	Gopalakrishna, Rajendra Arcot	370/469
*	F	US-6,643,292 B2	11-2003	Chapman et al.	370/395.52
*	G	US-2003/0223433 A1	12-2003	Lee et al.	370/395.52
*	Η	US-2004/0042487 A1	03-2004	Ossman, Valentin	370/466
*	I	US-6,791,982 B2	09-2004	Westberg, Lars	370/392
*	J	US-2004/0243710 A1	12-2004	Mao, Xiaolei	709/227
*	К	US-2005/0018651 A1	01-2005	Yan et al.	370/352
*	L	US-6,975,647 B2	12-2005	Neale et al.	370/466
*	М	US-6,987,771 B2	01-2006	Shimizu et al.	370/401

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

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# Notice of References Cited Application/Control No. 10/571,189 Examiner ZEWDU BEYEN Applicant(s)/Patent Under Reexamination FARRELL ET AL. Page 2 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,068,647 B2	06-2006	Fangman et al.	370/352
*	В	US-2007/0086454 A1	04-2007	Grinfeld, Ron	370/389
*	С	US-7,274,706 B1	09-2007	Nguyen et al.	370/419
*	D	US-7,305,493 B2	12-2007	McAlpine et al.	709/250
*	Е	US-7,333,498 B2	02-2008	Duisenberg et al.	370/395.71
*	F	US-2002/0044556	04-2002	Ando et al.	370/395.42
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.